


Search Notes 	Application/Control No. 10572085	Applicant(s)/Patent Under Reexamination SHIN ET AL.
	Examiner ZEWDU BEYEN	Art Unit 2416

SEARCHED			
Class	Subclass	Date	Examiner
370	395.54	20090619	zb
709	222-229(text only)	20090619	zb

SEARCH NOTES		
Search Notes	Date	Examiner
I did inventor search on PLAM	20090619	ZB
Database used ---EAST (US-PGPUB,USPAT,FPRS,EPO,JPO,DERWENT)	20090619	ZB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--